

Theoretical Simulations on Electric Properties of CNT-Me and GNR-Me Interconnects Using Effective Media Approach

Yu.N. Shunin^{1,2}, Yu.F. Zhukovskii², N. Burlutskaya¹, S. Bellucci³

¹ Information Systems Management Institute, Ludzas Str. 91, LV-1003 Riga, Latvia, +371 67100593, shunin@isma.lv

² Institute of Solid State Physics, University of Latvia, Kengaraga Str. 8, LV-1063 Riga, Latvia, +371 67187480, quantzh@latnet.lv

³ INFN - Laboratori Nazionali di Frascati, Via Enrico Fermi 40, I-00044, Frascati (Rome), Italy, +39 0694032888, Stefano.Bellucci@Inf.infn.it

INTRODUCTION

This research pays the basic attention to the junctions of CNTs and GNRs with contacting metallic elements of a nanocircuit. We have simulated interconnects for both single-wall (SW) and multi-wall (MW) carbon nanotubes (CNTs) as well as single-layered (SL) and multi-layered (ML) graphene nanoribbons (GNRs) with different morphology (Fig.1).

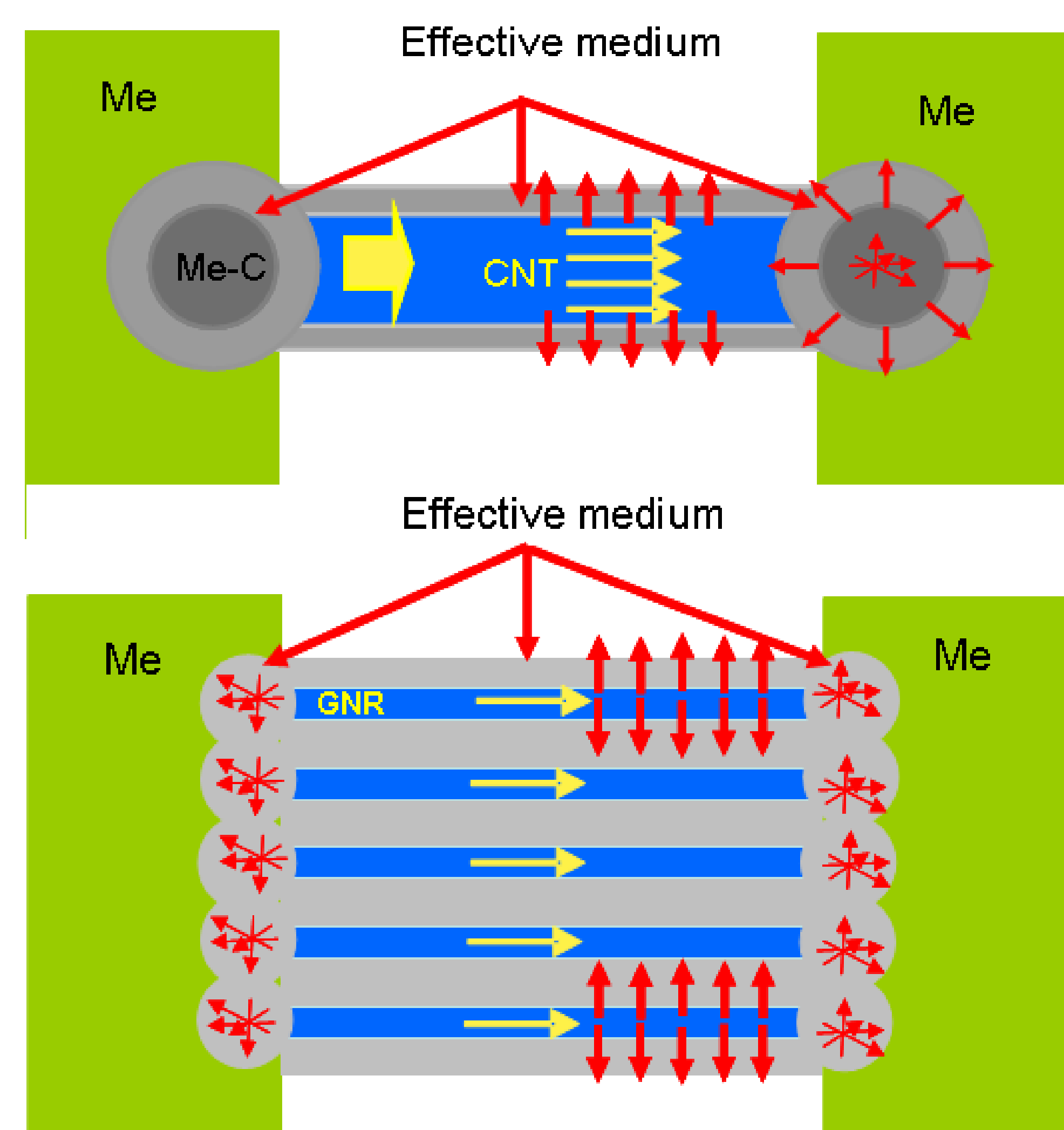


Figure 1. Prototype of Novel Nanodevices: a) CNT-Me interconnect Based Nanodevice b) GNR (multilayered) - Me interconnect Based Nanodevice

CNT-Me AND GNR-Me MODELS IN THE EFFECTIVE MEDIUM APPROACH

The electronic structure of the CNT-Me and GNR-Me interconnects can be evaluated through the electronic density of states (EDOS) for C-Me contact considered as a 'disordered alloy', where clusters containing both C and Me atoms behave as scattering centers. The computational procedure developed by us for these calculations is based on the construction of cluster potentials and the evaluation of both scattering (S) and transfer (T) matrices¹.

The general model of multiple scattering using the effective media approximation (EMA) combined with a coherent potential approach (CPA) for condensed matter is based on the atomic cluster formalism. When using the CPA as EMA approximation, the resistance of interconnect is evaluated through the Kubo-Greenwood formalism² or Ziman model³.

We consider the resistivity as a scattering problem, where the current carriers participate in the transport, according to various mechanisms based on the presence of scattering centers (phonons, charge defects, structural defects, etc.), including a pure elastic way defined as ballistic (Matissien rule).

We have developed structural models for CNT-Me and GNR-Me junctions, based on their precise atomistic structures, which take into account the chirality effect and its influence on the interconnect resistance for Me (= Ni, Cu, Ag, Pd, Pt, Au) and predefined CNT (or GNR) geometry, taking into account the d -dimensional properties of atomic structures¹.

SIMULATION OF CNT-Me AND GNR-Me INTERCONNECTS: MODEL OF 'EFFECTIVE BONDS'

The 'effective bonds' model of the CNT-Me⁴ and GNR-Me interconnects (Fig. 2) is developed in the current study. It consists of two regions supporting the two different electron transport mechanisms: *ballistic* (elastic) and *collisional* (non-elastic).

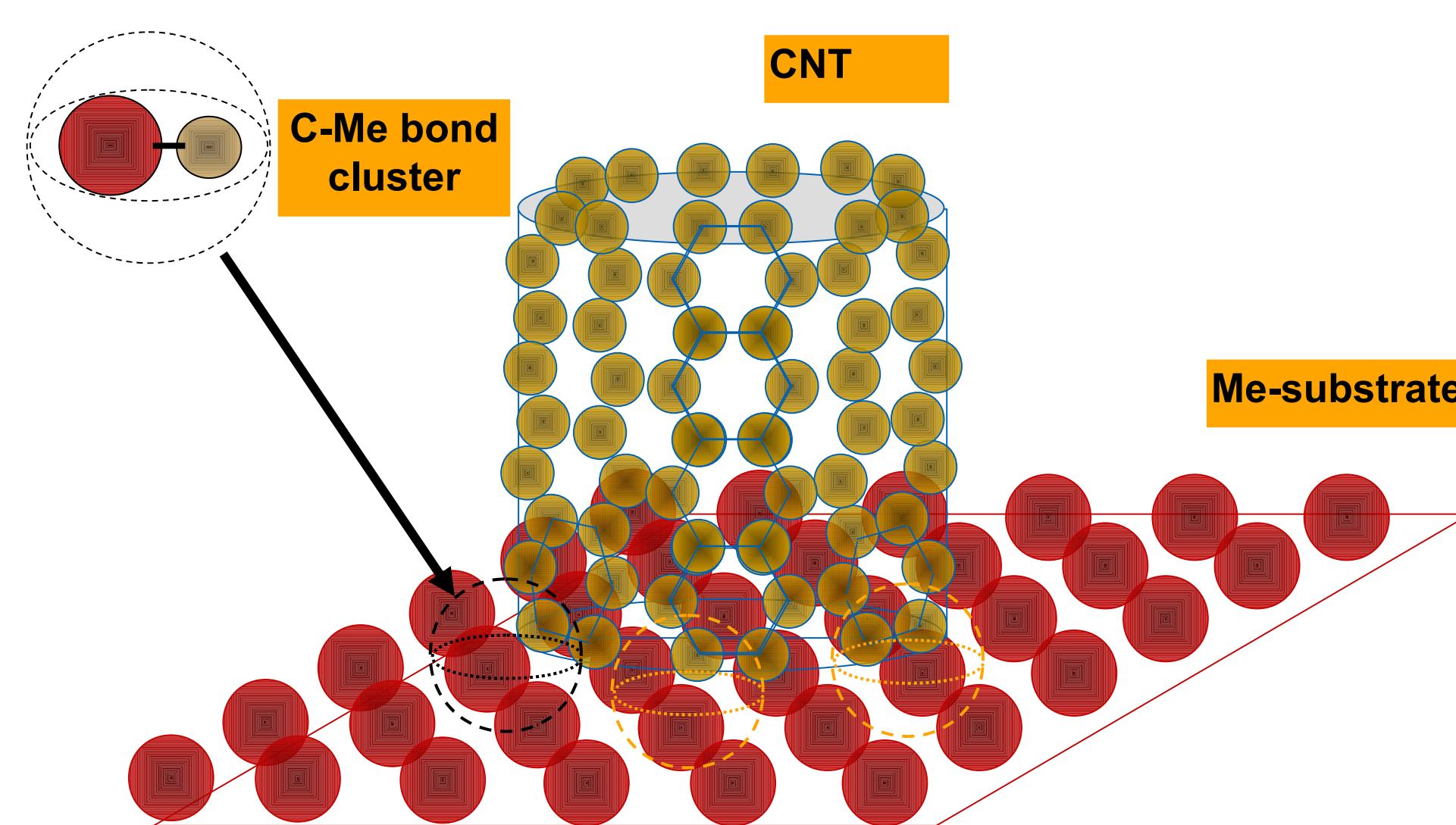


Figure 2. The SW CNT-Me interconnect: model of "effective bonds".

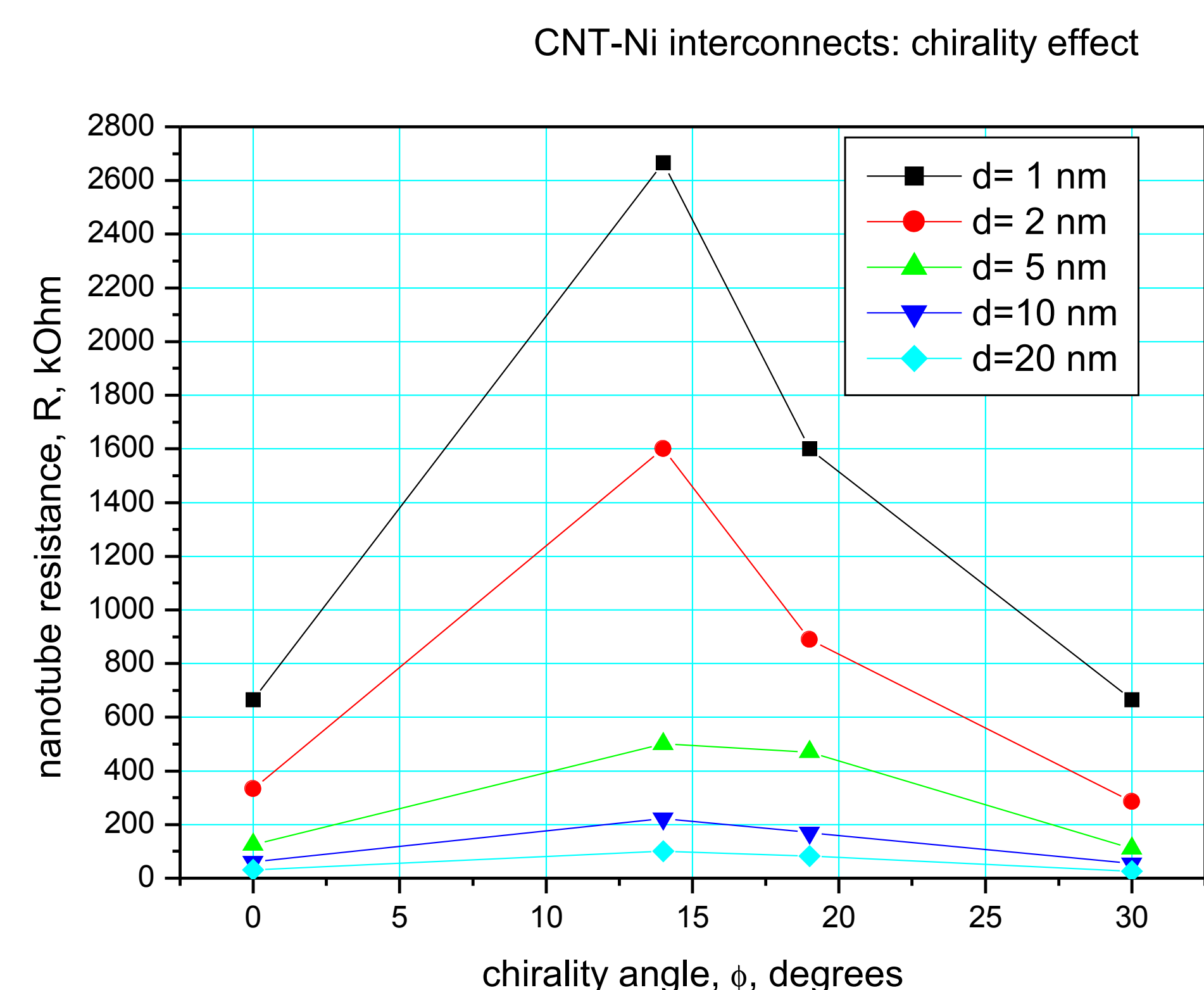


Figure 3. Resistance of CNT-Ni junction vs. NT diameter

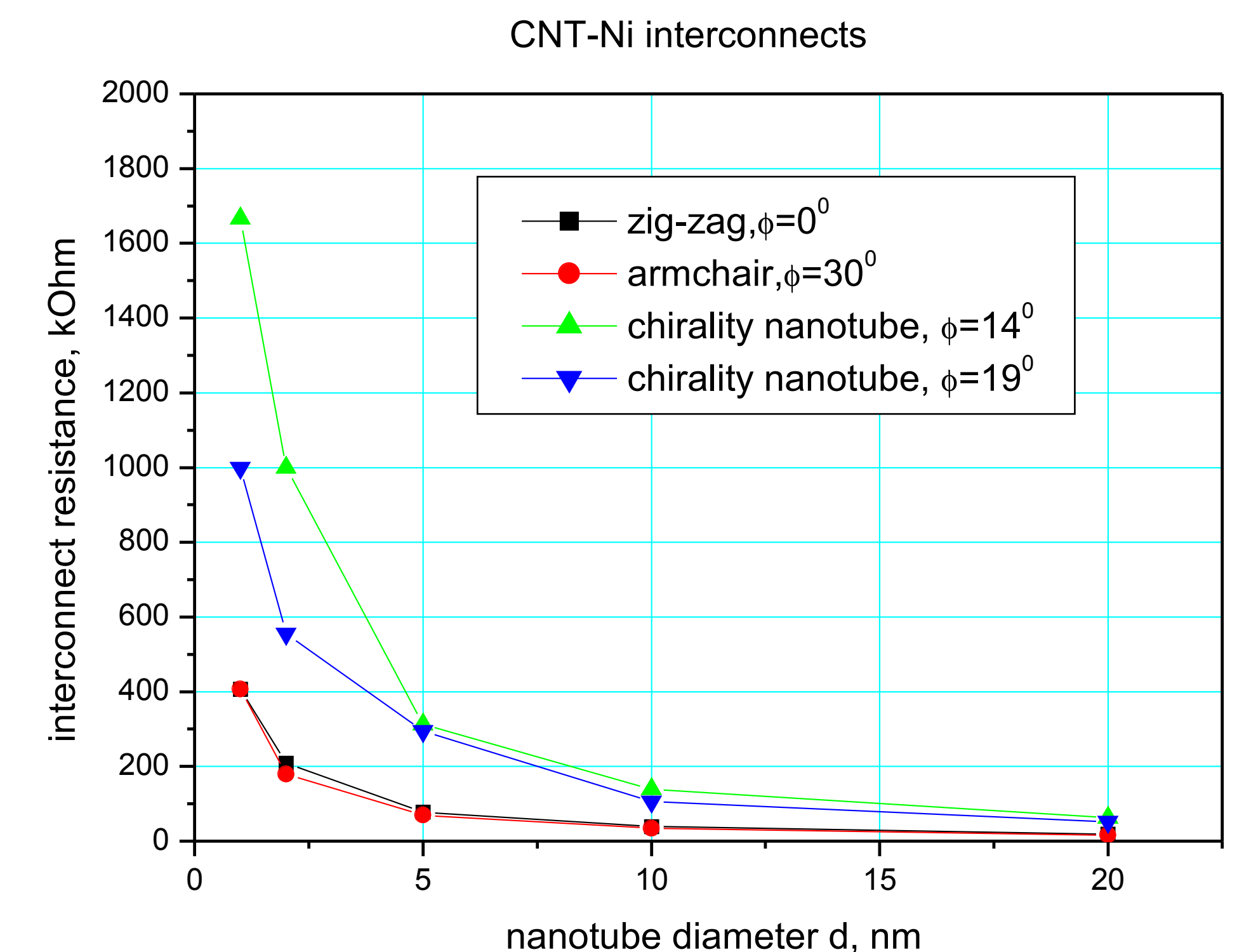


Figure 4. CNT-Ni interconnect: chirality effects

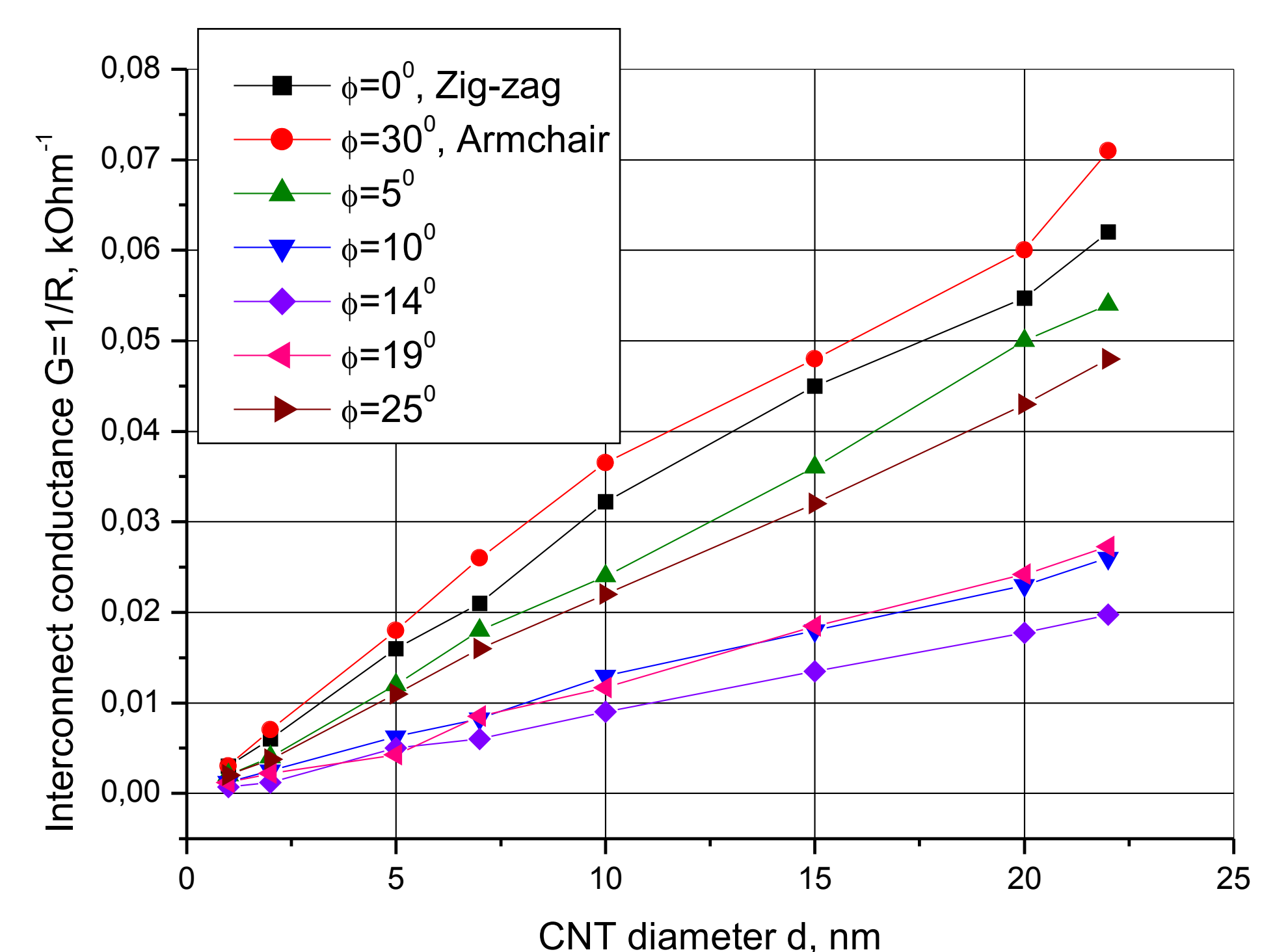


Figure 5. Parametric calculations of conductance for CNT-Au interconnects with various chirality angles

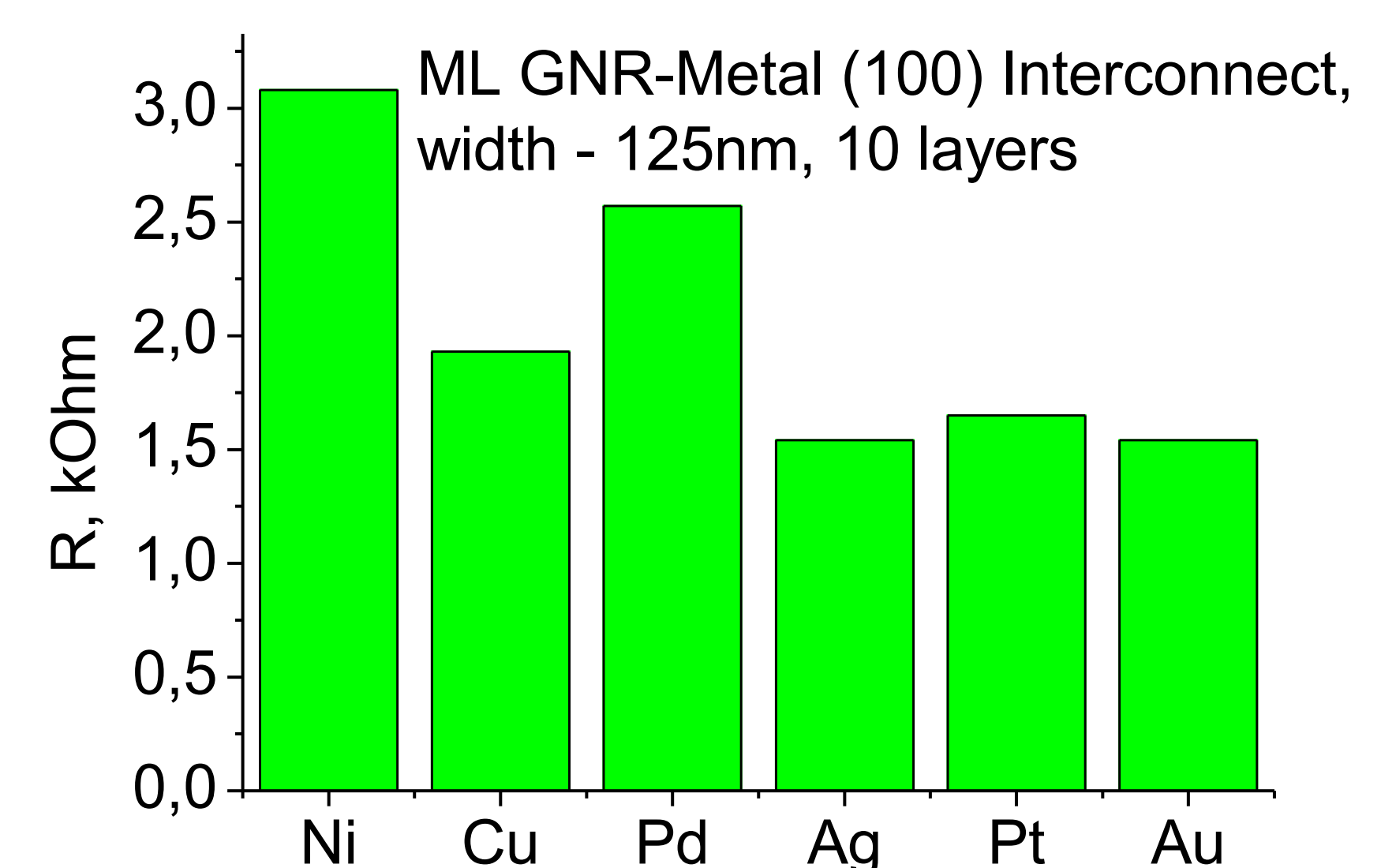


Figure 6. MLGNR-Me Interconnects resistances

Resume: CNT-Au contact is electrically more preferable as compared to contacts of nanotubes with other metal substrates. We have also developed the model of inter-shell interaction for the MW CNTs and multi-layer (ML) GNRs, which allows us to estimate the transparency coefficient as an indicator of possible 'current' losses.

ACKNOWLEDGMENTS

This work has been supported by grant FR7-ICT-2007-1, Proposal 21625 CATHERINE (2008-2011): Carbon nAnotube Technology for High-speed nExt-geneRation nano-InterconNEcts. Authors are also grateful to Prof. E. Kotomin, Prof. M.-S. Sarto for stimulating discussions.

References

- [1] Yu.N. Shunin, K.K. Schwartz, Correlation between electronic structure and atomic configurations in disordered solids. In: *Computer Modeling of Electronic and Atomic Processes in Solids* (Eds: R.C. Tennyson, A.E. Kiv; Kluwer Acad. Publisher, Dodrecht, Boston, London, 1997) p. 241-257.
- [2] E.L. Economou, *Green's Functions in Quantum Physics*. Solid State Ser. Vol. 7 (3rd edition; Springer Verlag, Berlin, Heidelberg, 2006).
- [3] J.M. Ziman, *Models of Disorder* (Cambridge University Press, London, New York, 1979).
- [4] Yu.N. Shunin, Yu.F. Zhukovskii, N. Burlutskaya, S. Bellucci, Resistance simulations for junctions of SW and MW carbon nanotubes with various metal substrates. *Central European Journal of Physics*, **9** (2011) 519-529.